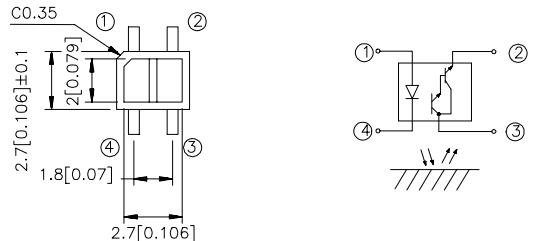


ATIR0821DS

Features

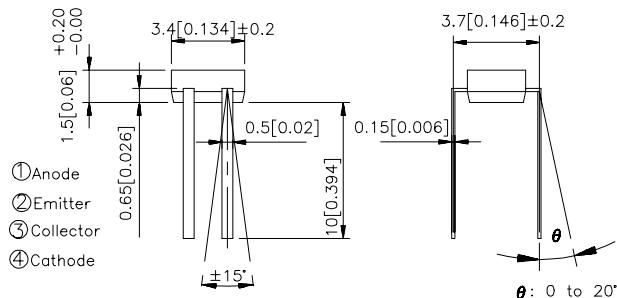
- Compact and thin.
- Visible light cut-off type.
- High sensitivity.

Package Dimensions



Applications

- Cassette tape recorders, VCRs.
- Floppy disk drives.
- Various microcomputerized control equipment.



Notes:

1. All dimensions are in millimeters (inches).
2. Tolerance is $\pm 0.25(0.01")$ unless otherwise noted.
3. Lead spacing is measured where the lead emerge package.
4. Specifications are subject to change without notice.

Absolute Maximum Ratings ($T_a=25^\circ\text{C}$)

Parameter		Symbol	Rating	Unit
Input	Forward current	I_F	50	mA
	Reverse voltage	V_R	5	V
	Power dissipation	P	75	mW
Output	Collector-emitter voltage	V_{CEO}	30	V
	Emitter-collector voltage	V_{ECO}	5	V
	Collector current	I_C	50	mA
	Collector power dissipation	P_C	75	mW
Operating temperature		T_{opr}	-25~+85	$^\circ\text{C}$
Storage temperature		T_{stg}	-40~+100	$^\circ\text{C}$
Soldering temperature (1/16 inch from body for 5 seconds)		T_{sol}	260	$^\circ\text{C}$

Electro-optical Characteristics ($T_a=25^\circ C$)

Parameter		Symbol	Conditions	Min.	Typ.	Max.	Unit
Input	Forward voltage	V_F	$I_F=20mA$	—	1.2	1.5	V
	Reverse current	I_R	$V_R=5V$	—	—	10	μA
Output	Collector dark current	I_{CEO}	$V_{CE}=10V, I_F=0mA$	—	—	10^{-6}	A
Transfer characteristics	* ¹ Collector current	I_C	$V_{CE}=2V, I_F=4mA$	—	3	—	mA
	* ² Leak current	I_{LEAK}	$V_{CE}=5V, I_F=4mA$	—	—	5	μA
	Response time	t_r	$V_{CE}=2V, I_C=10mA$	—	80	400	μsec
	Fall time	t_f	$R_L=100\Omega, d=1mm$	—	70	400	μsec

*1 The condition and arrangement of the reflective object are shown below.

*2 Without reflective object.

Test Condition and Arrangement for Collector Current

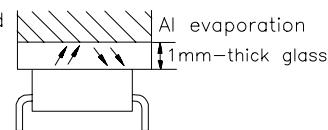


Fig.1 Forward Current vs. Forward Voltage

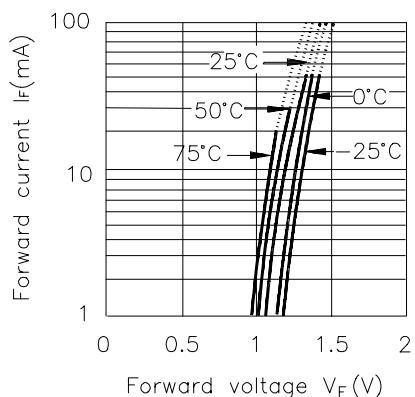


Fig.2 Collector Current vs. Forward Current

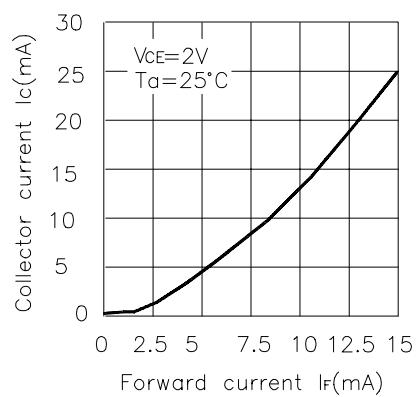


Fig.3 Collector Current vs. Collector-emitter Voltage

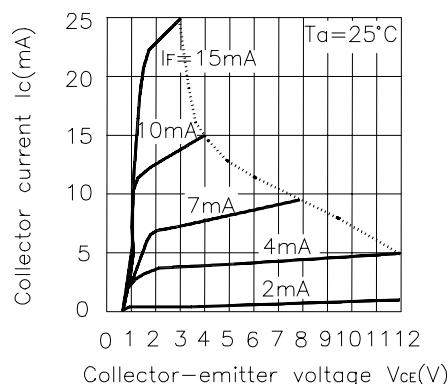


Fig.4 Relative Collector Current vs. Ambient Temperature

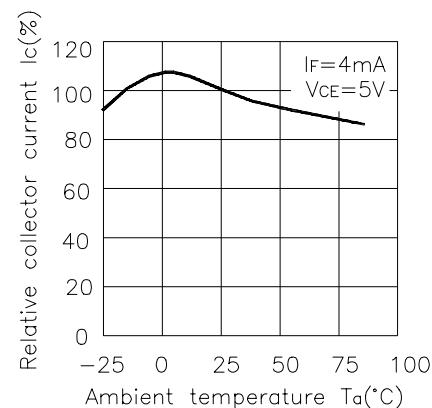
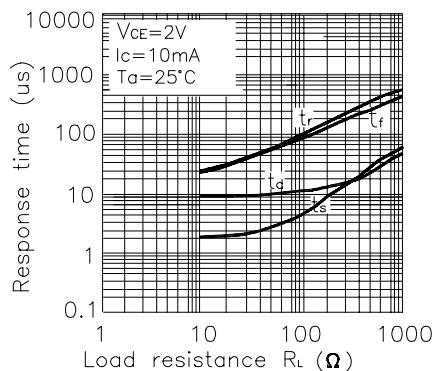


Fig.5 Response Time vs Load Resistance



Test Circuit for Response Time

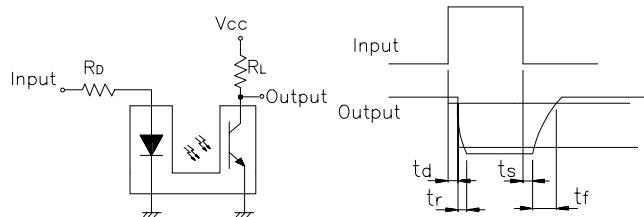


Fig.6 Collector Dark Current vs Ambient Temperature

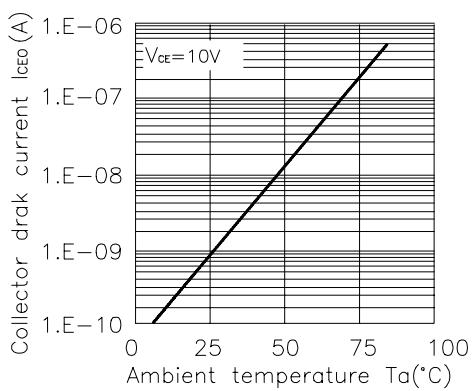


Fig.7 Relative Collector Current vs Distance between Sensor and Al Evaporation Glass

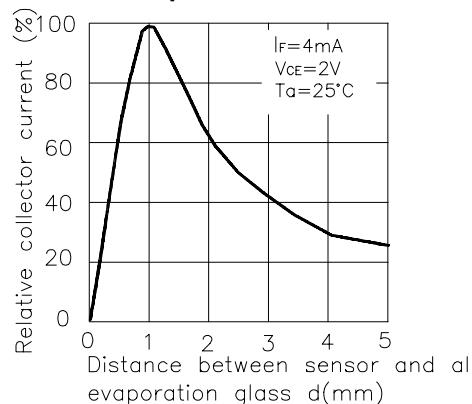


Fig.8 Relative Collector Current vs Card Moving Distance (1)

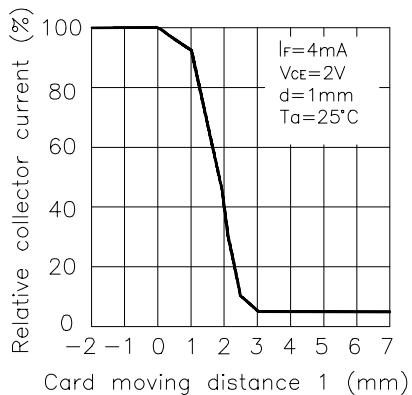
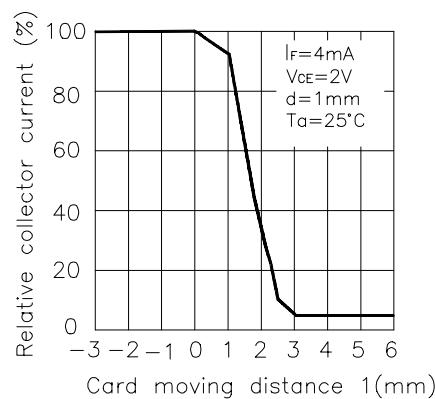


Fig.9 Relative Collector Current vs Card Moving Distance (2)



Test Condition for Distance&Detecting Position Characteristics

Correspond to Fig.7

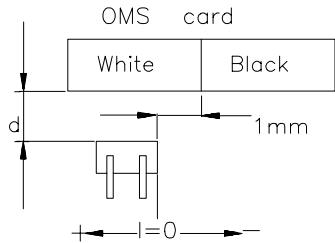


Correspond to Fig.8
Test condition

$I_F = 4\text{mA}$

$V_{CE} = 2\text{V}$

$d = 1\text{mm}$



Correspond to Fig.9
Test condition

$I_F = 4\text{mA}$

$V_{CE} = 2\text{V}$

$d = 1\text{mm}$

